

Notice of References Cited

Application/Control No.

10/532,724

Applicant(s)/Patent Under
Reexamination
SUDO, TAKASHI

Examiner

Allen J. Flanigan

Art Unit

3744

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,410,036 A	10-1983	Kanada et al.	165/134.1
*	B	US-4,716,959 A	01-1988	Aoki, Hisao	165/152
*	C	US-5,054,549 A	10-1991	Nakaguro, Kazuhiro	165/133
*	D	US-5,072,789 A	12-1991	Usui et al.	165/134.1
*	E	US-5,099,912 A	03-1992	Tajima et al.	165/133
*	F	US-5,125,452 A	06-1992	Yamauchi et al.	165/133
*	G	US-6,129,143 A	10-2000	Hasegawa et al.	165/133
*	H	US-6,261,706 B1	07-2001	Fukuda et al.	428/654
*	I	US-2001/0010262 A1	08-2001	Komoda, Shuji	165/167
*	J	US-2002/0037426 A1	03-2002	Yamada et al.	428/654
*	K	US-6,627,330 B1	09-2003	Shimizu et al.	428/654
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 01075893 A	03-1989	Japan	ISHII et al.	F28F 19/06
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.